

The SENSEI[†] project

how to look for DM-electron scattering events

Javier Tiffenberg

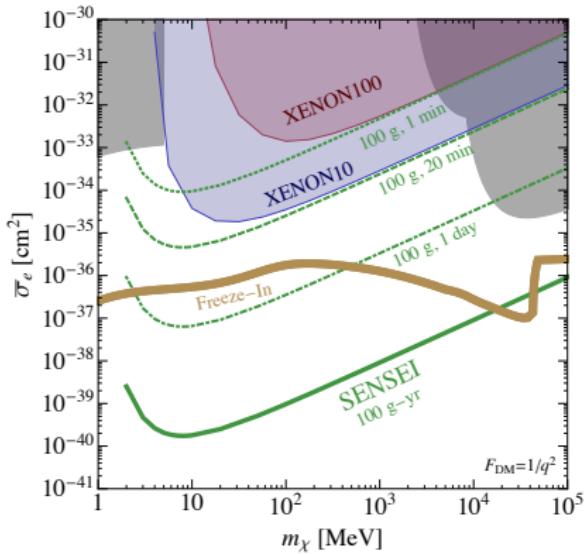
Fermi National Laboratory

March 25, 2017

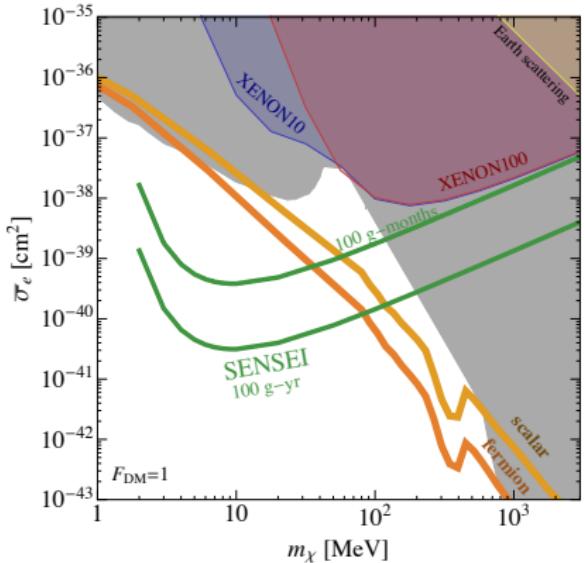
† Sub-Electron-Noise SkipperCCD Experimental Instrument

Motivation for SENSEI: a detector that can do this NOW

Light Dark Photon



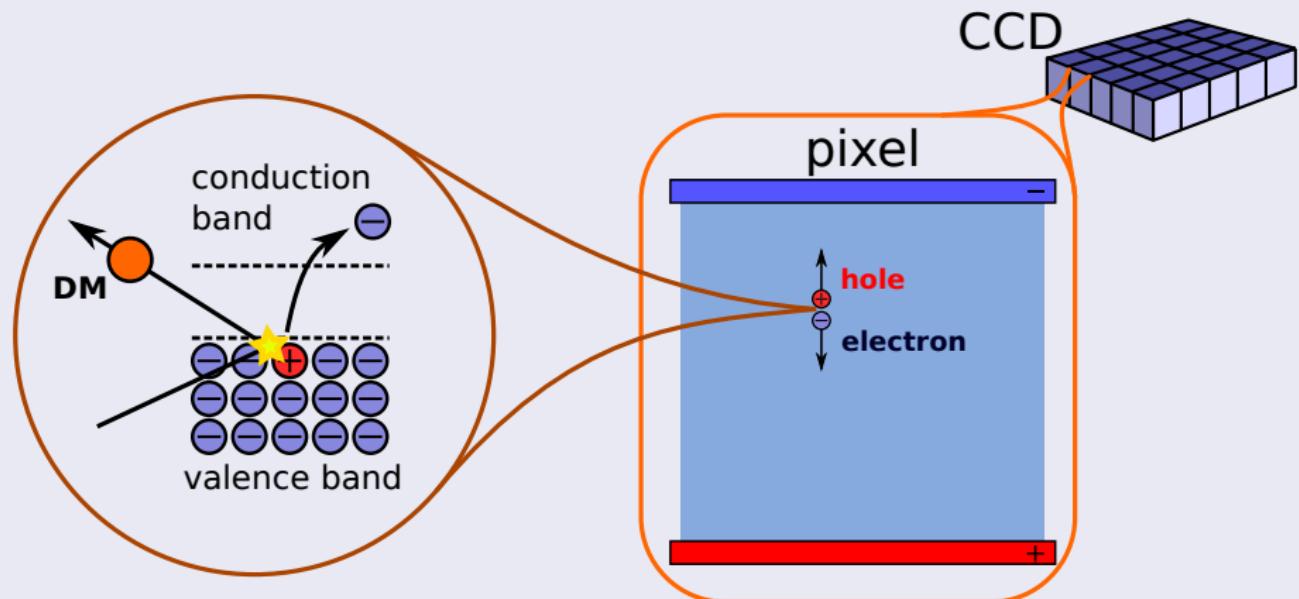
Heavy Dark Photon



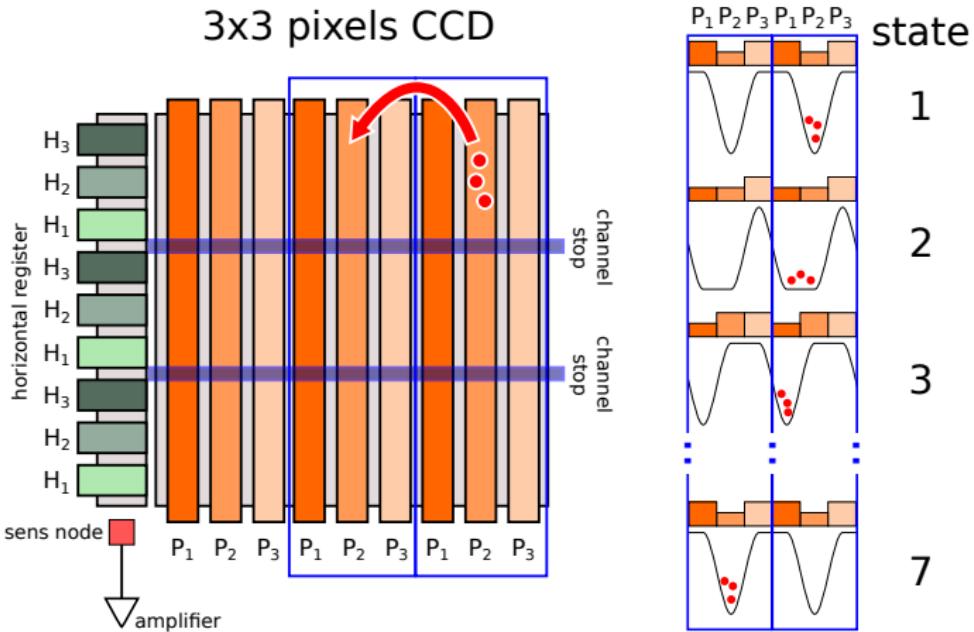
Plots from: Rouven Essig, Tomer Volansky & Tien-Tien Yu.

How?

use CCDs as target to record the ionization produced by DM

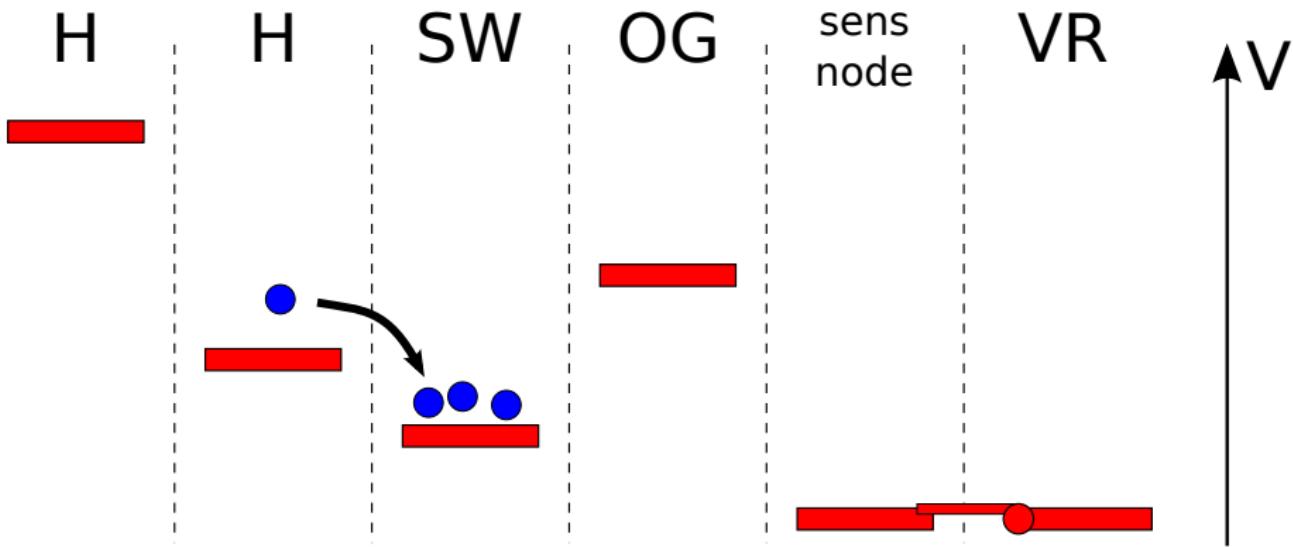


CCD: readout



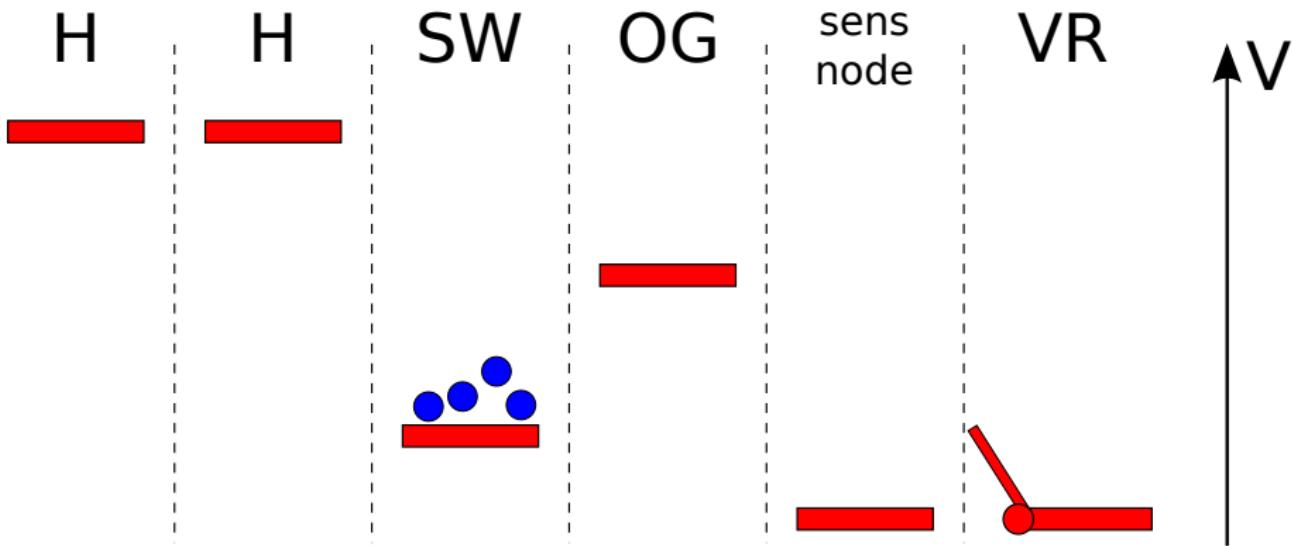
capacitance of the system is set by the SN: $C=0.05\text{pF} \rightarrow 3\mu\text{V/e}$

CCD: readout

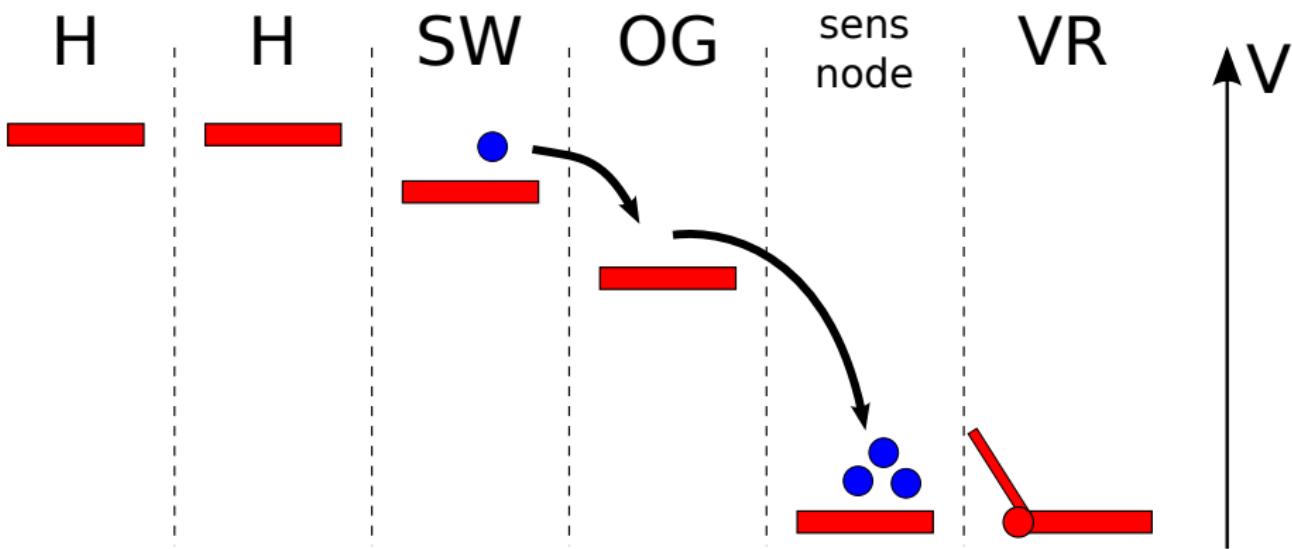


Accumulate the charge in the SW and reset the SN voltage

CCD: readout

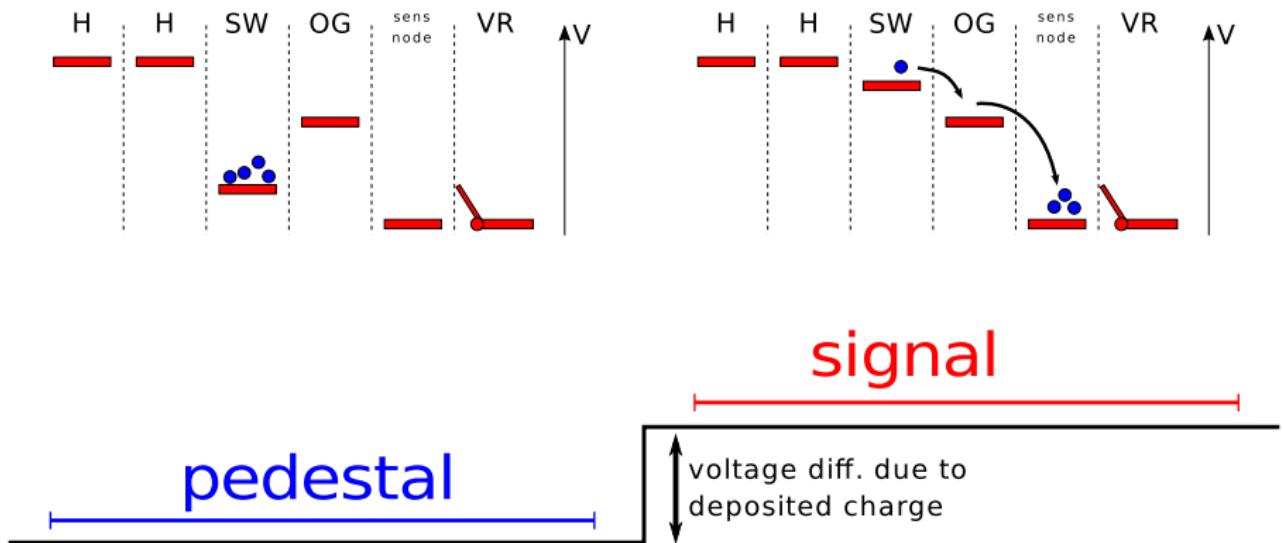


Disconnect the SN so it's floating. Measure the baseline voltage in the SN.



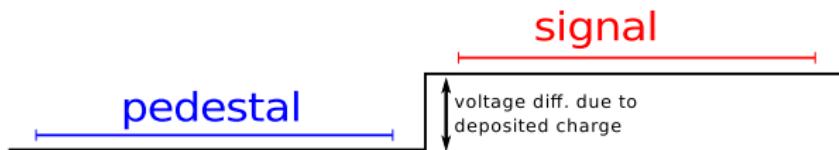
Move the charge to the SN and measure the shift in the voltage

CCD: readout

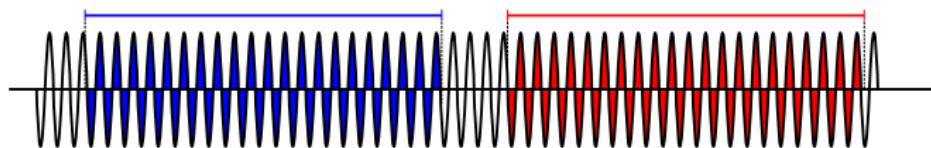


CCD: readout

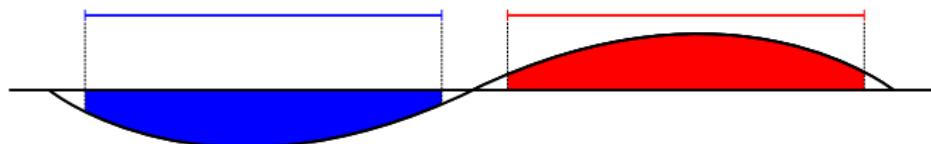
pixel charge measurement



high frequency noise

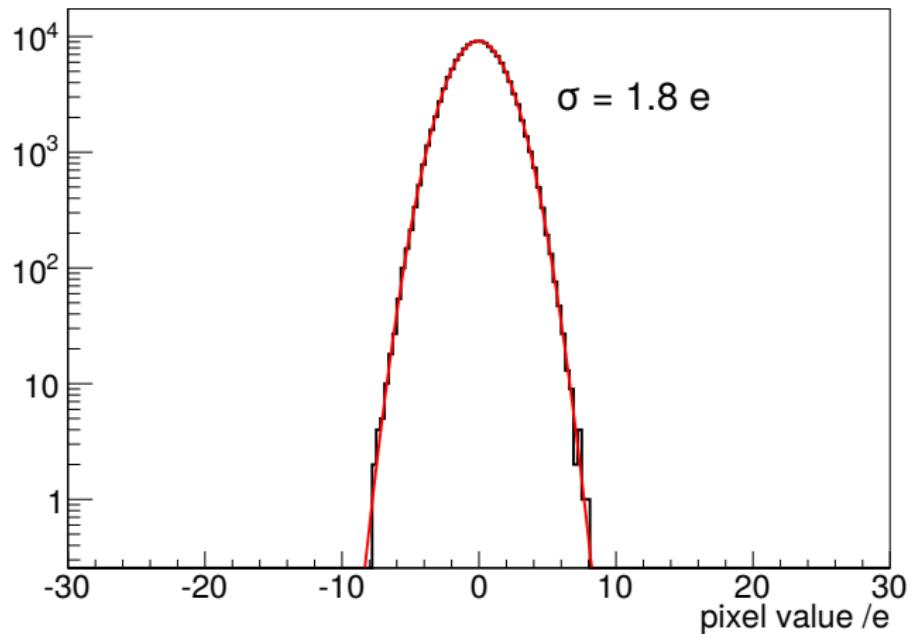


low frequency noise



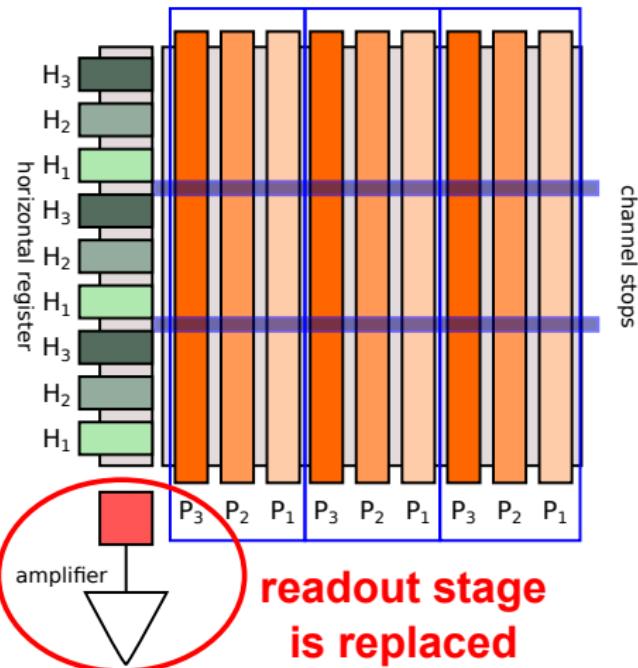
excellent for removing high frequency noise but sensitive to low frequencies

Readout noise: empty pixels distribution



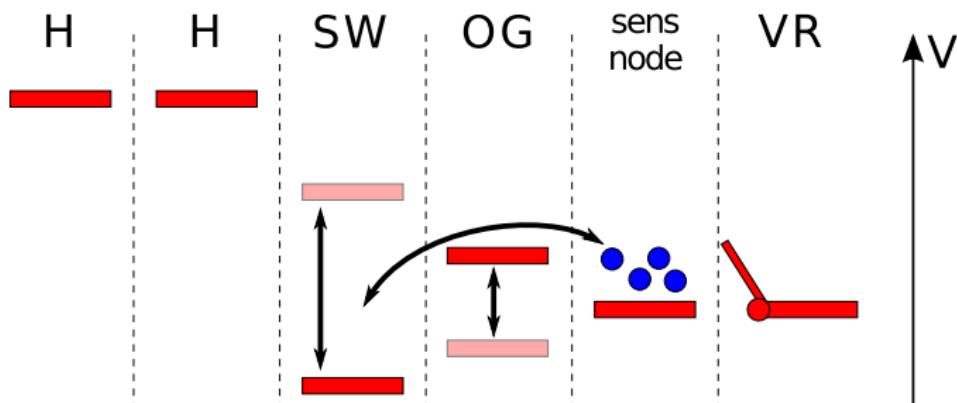
2 e^- readout noise roughly corresponds to 50 eV energy threshold

Lowering the noise: Skipper CCD



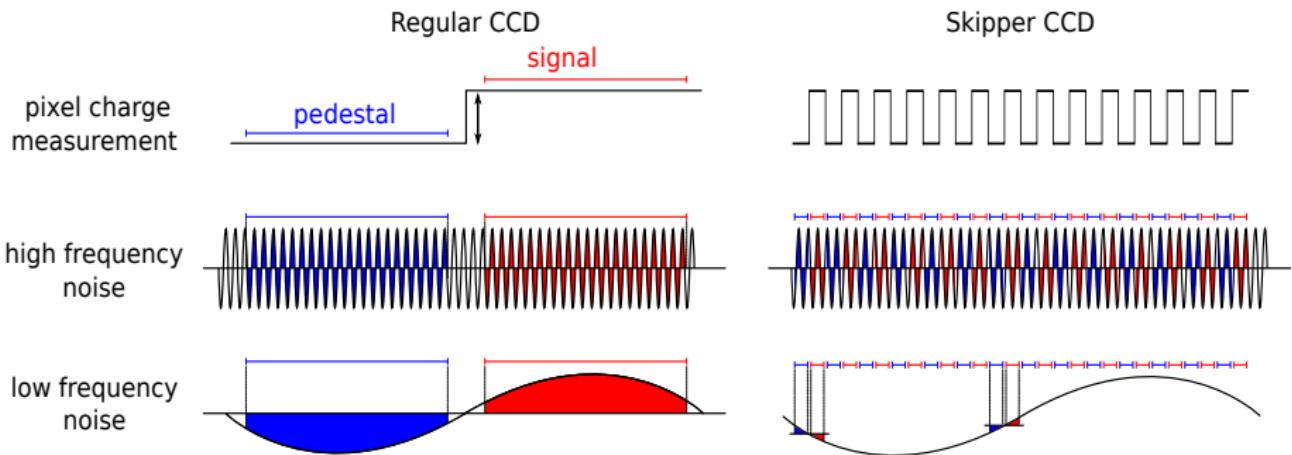
Lowering the noise: Skipper CCD

- **Main difference:** the Skipper CCD allows multiple sampling of the same pixel without corrupting the charge packet.
- The final pixel value is the average of the samples
Pixel value = $\frac{1}{N} \sum_i^N (\text{pixel sample})_i$
- Idea proposed in 1990 by Janesick et al. (doi:10.1117/12.19452)



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Awarded proposal: **Fermilab LDRD 2016** - PI Javier Tiffenberg

Develop a CCD-based detector with an energy threshold close to the silicon band gap (1.1 eV) and a readout noise of 0.1 electrons using a new generation skipper CCD developed by the **LBNL MicroSystems Lab**

Plan

- Build the first working detector using Skipper-CCDs.
- Optimize the operation parameters and running conditions.
- Produce a low radiation package for the Skipper-CCDs.
- Install the detector in a low radiation environment (MINOS).
- Validate the technology for DM and ν experiments.

SENSEI: First working instrument using SkipperCCD tech

Sensors



- Skipper-CCD prototype designed by **LBL MSL**
- 200 & 250 μm thick, 15 μm pixel size
- Two form factors $4\text{k}\times 1\text{k}$ (0.5gr) & $1.2\text{k}\times 0.7\text{k}$ pixels
- Parasitic run, optic coating and Si resistivity $\sim 10\text{k}\Omega$
- 4 amplifiers per CCD, three different RO stage designs

Instrument



- System integration done at Fermilab
- Custom cold electronics
- Modified DES electronics for read out
- Firmware and image processing software
- Optimization of operation parameters

Image taken with SENSEI: 4000 samples per pixel (processed)

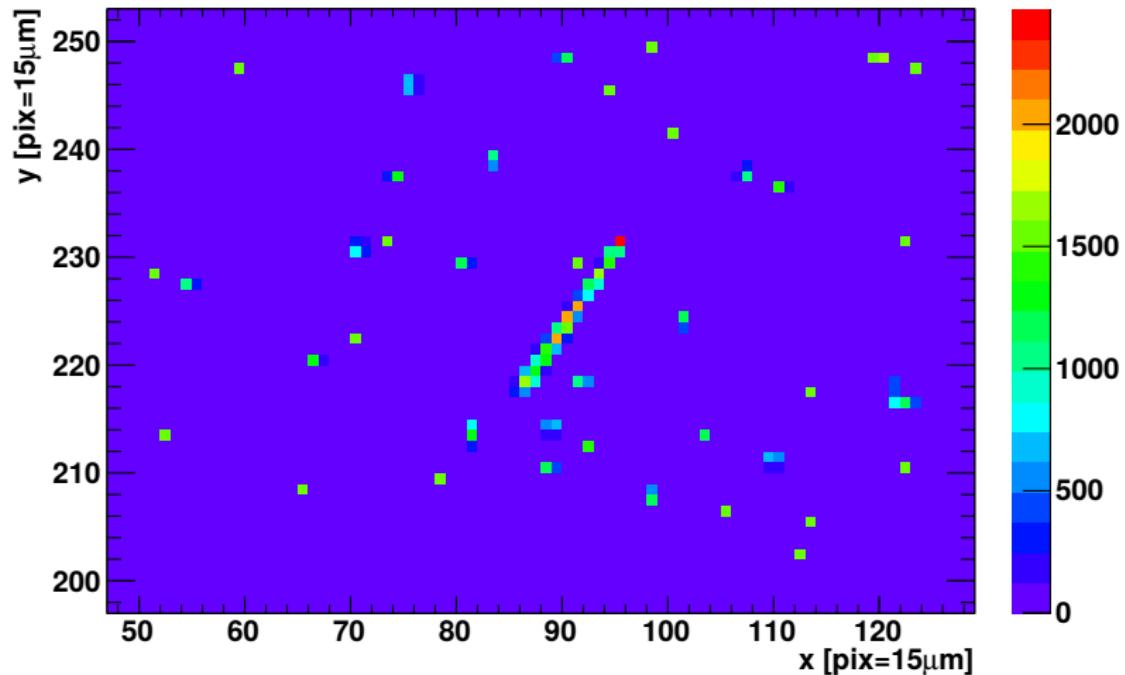


Image taken with SENSEI: 4000 samples per pixel (processed)

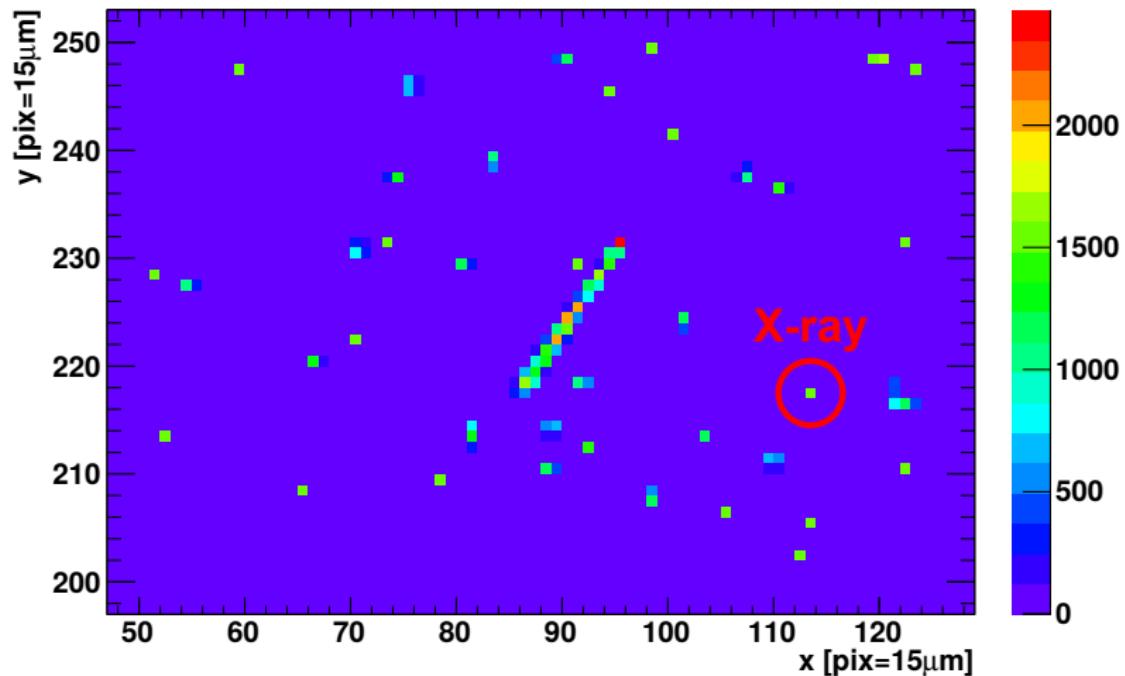


Image taken with SENSEI: 4000 samples per pixel (processed)

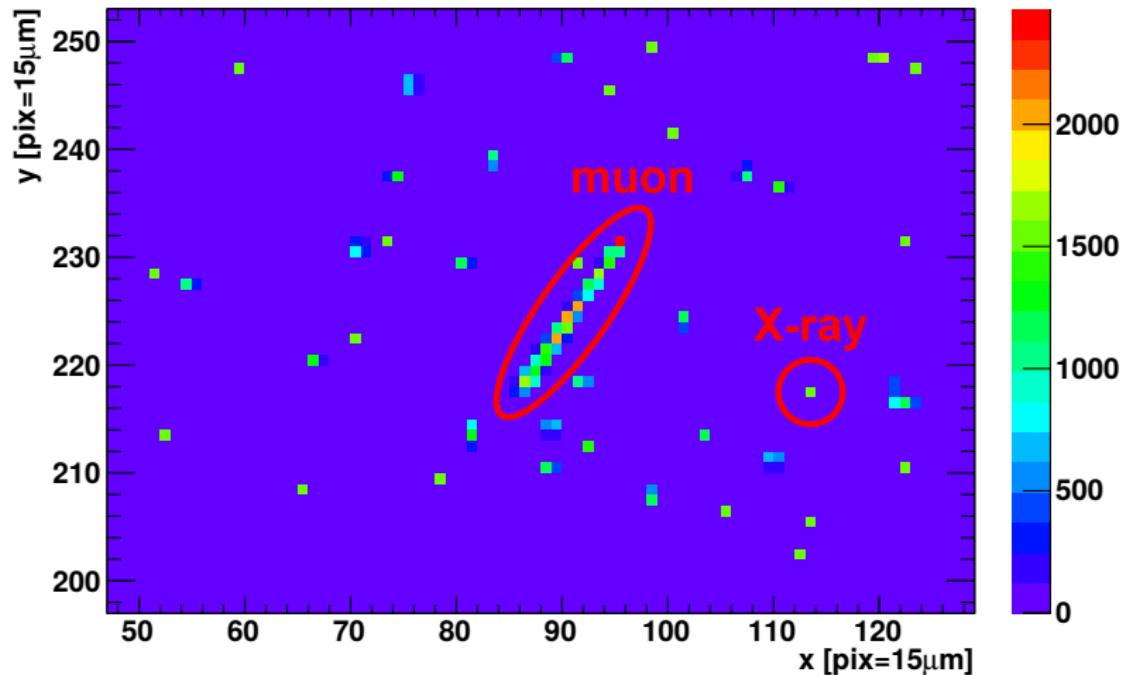
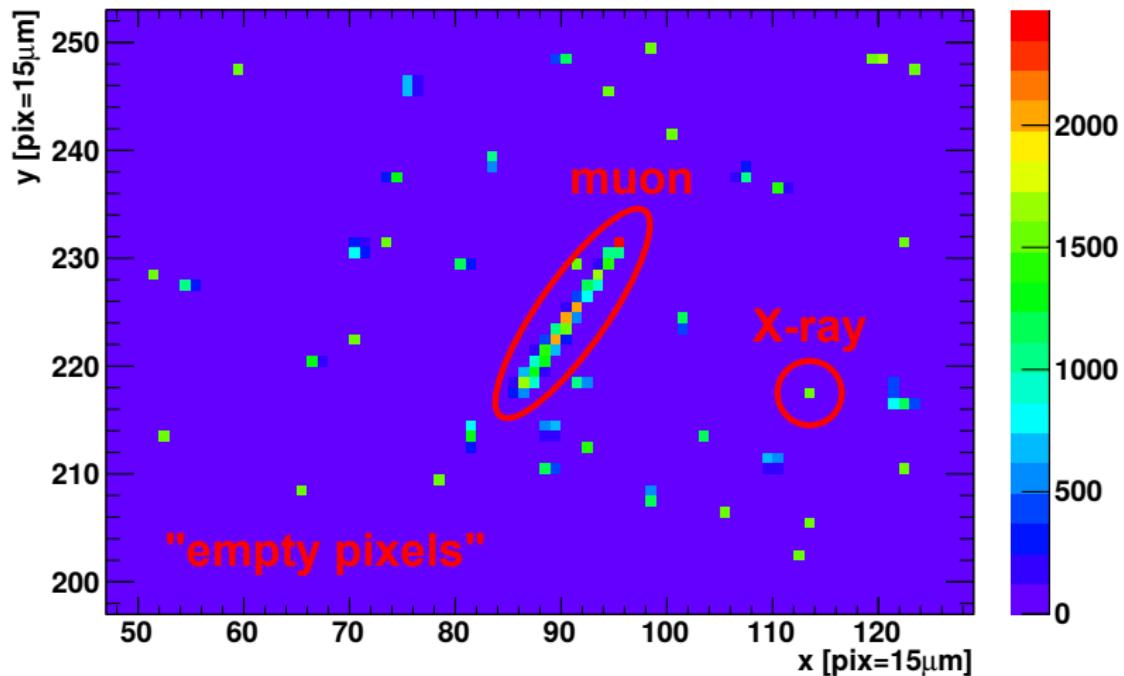
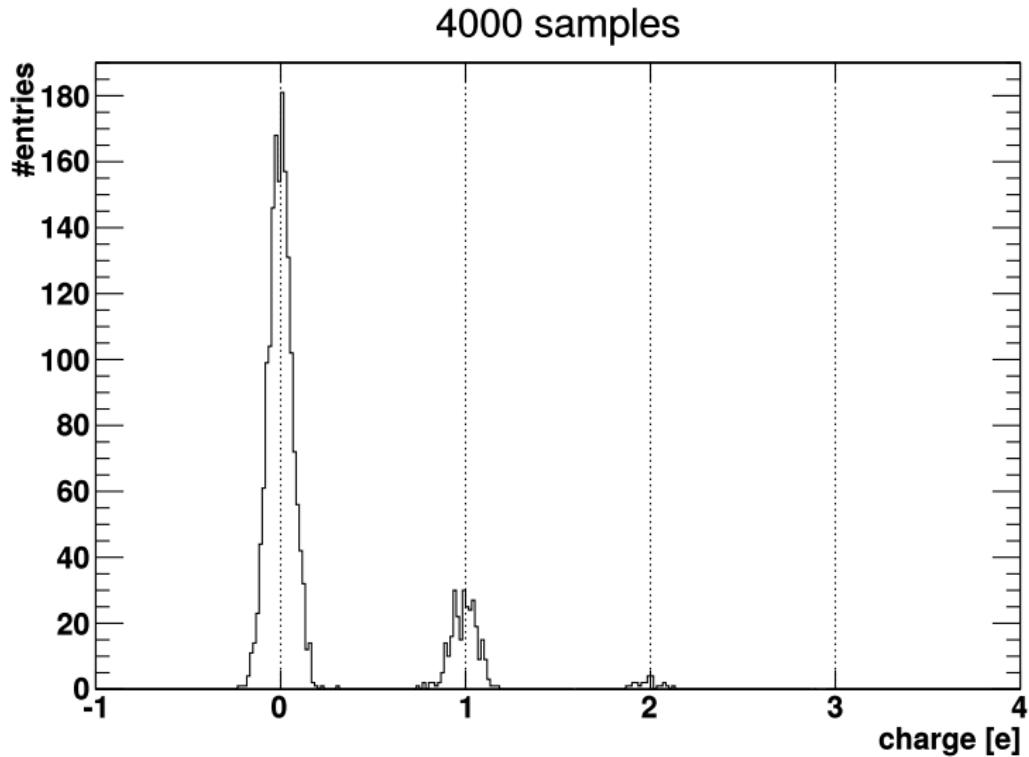


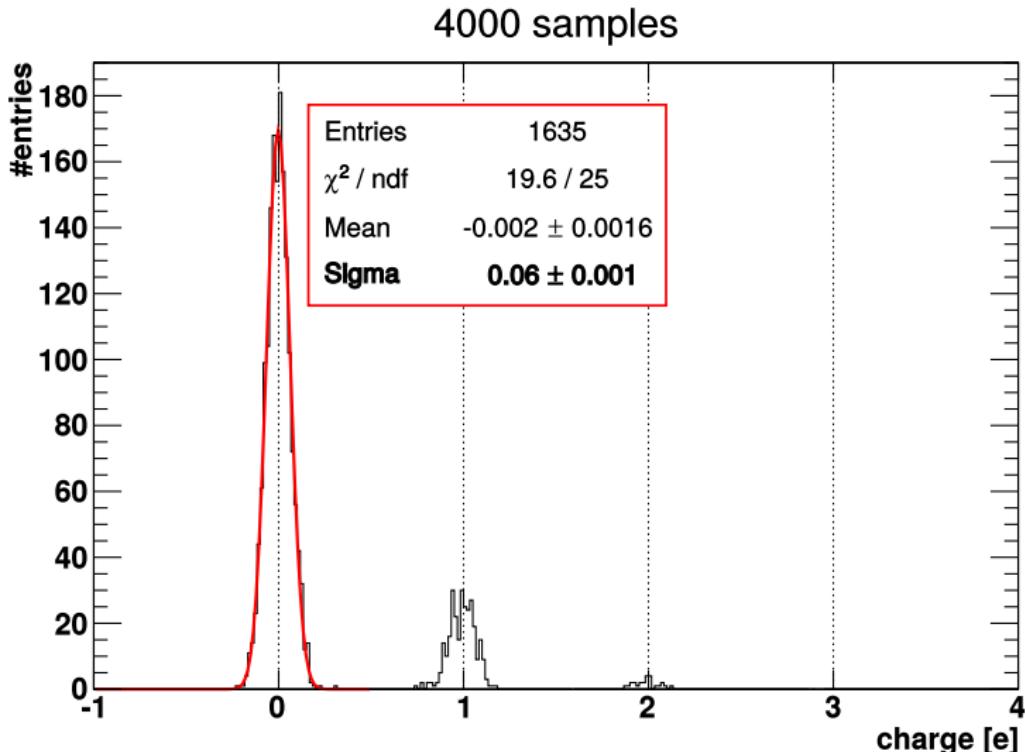
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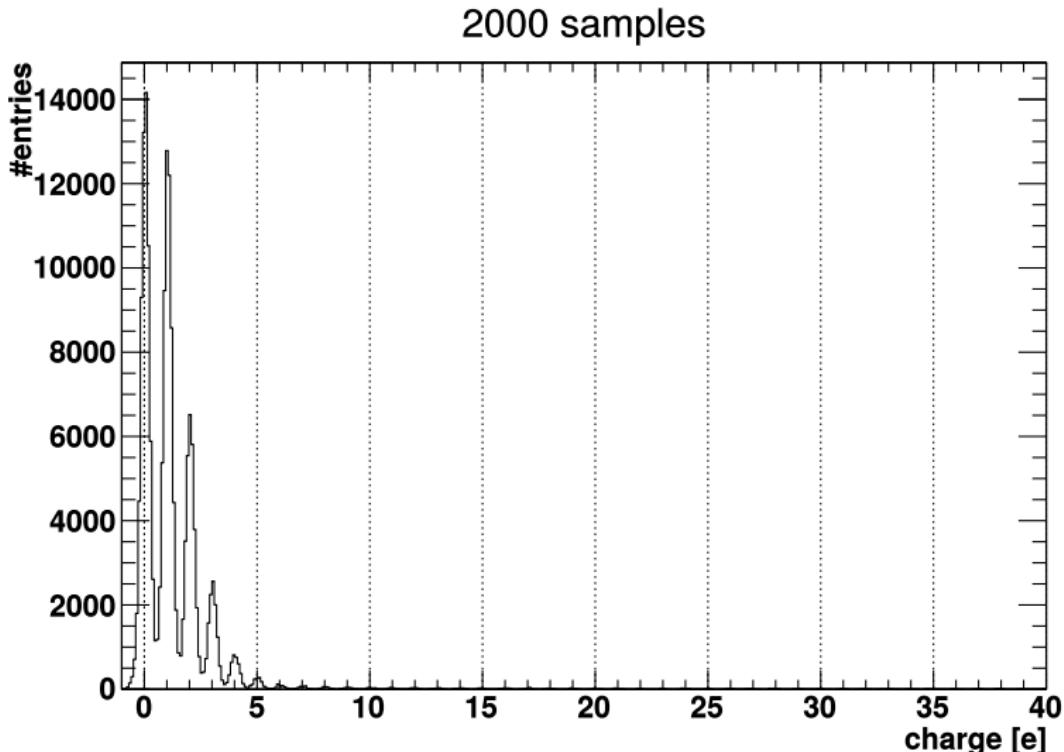
Charge in pixel distribution. Counting electrons: 0, 1, 2..



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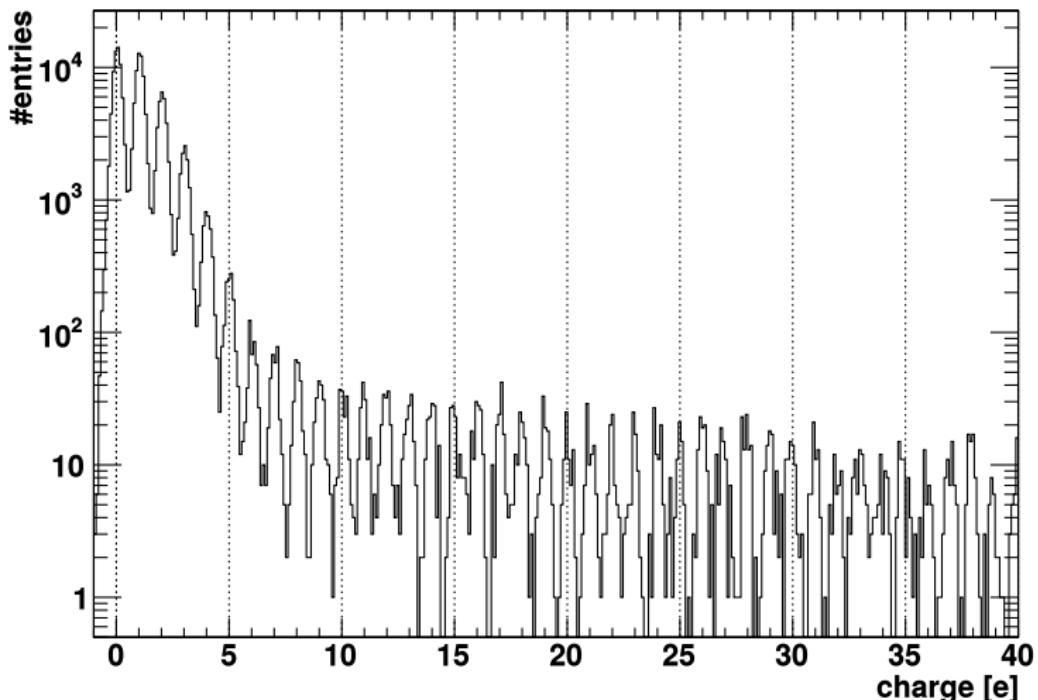


Counting electrons: ..38, 39, 40..

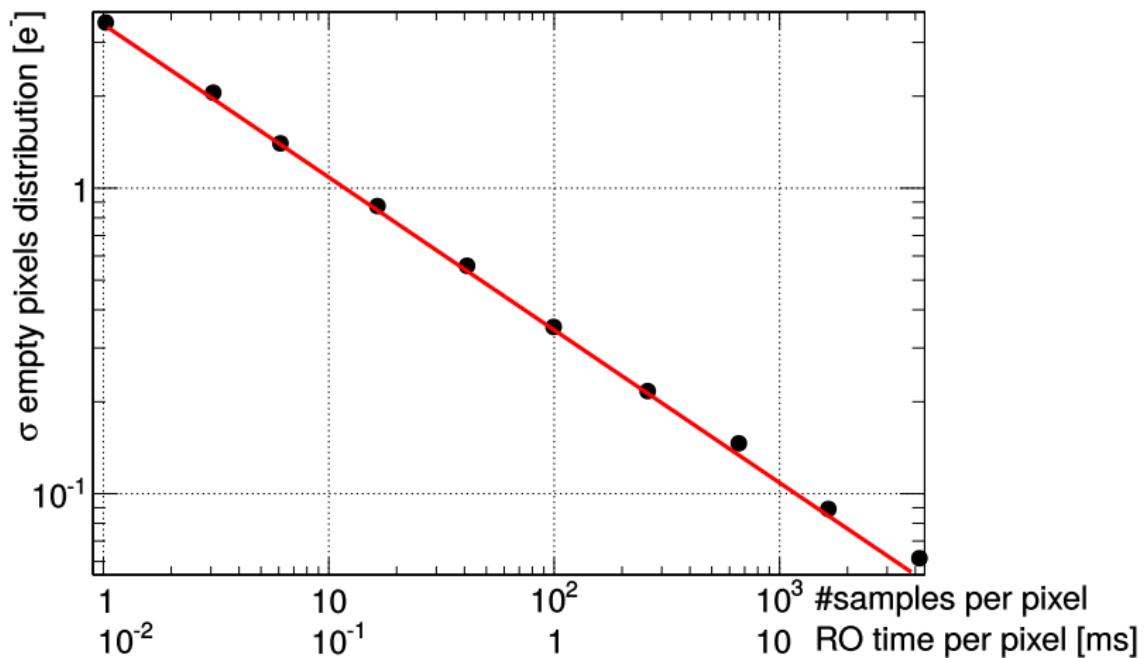


Counting electrons: ..38, 39, 40..

2000 samples

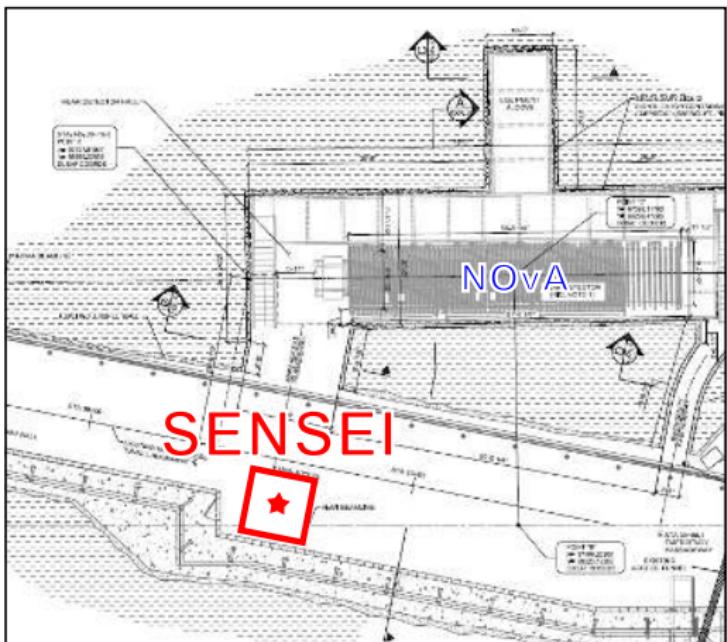
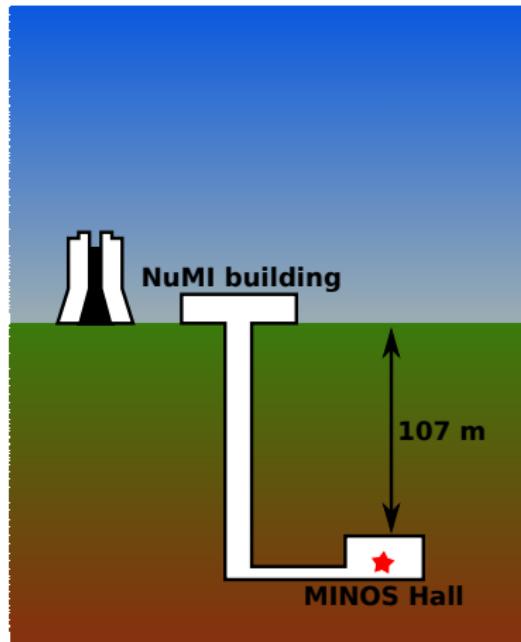


Noise vs. #samples - $1/\sqrt{N}$

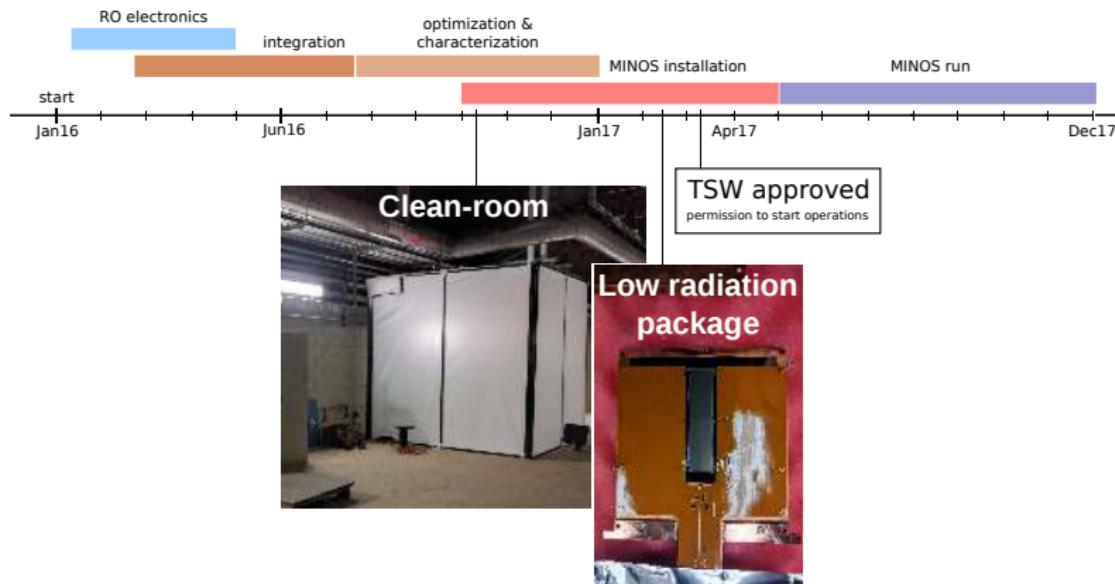


What's next: Installation @MINOS & low radiation package

Technology demonstration: installation at shallow underground site



What's next: Installation @MINOS & low radiation package



Commissioning of 1gr at MINOS by the end of April 2017



SENSEI: DM search operation mode

- Counting electrons \Rightarrow **noise has zero impact**
- It can take about 1h to readout a 4kx4k sensor
- **Dark Current is the limiting factor**

It's better to readout continuously to minimize the impact of the DC

Number of DC events (100 g y)		
Thr /e	$DC = 1 \times 10^{-3} \text{ e pix}^{-1}\text{day}^{-1}$	$DC = 10^{-5} \text{ e pix}^{-1}\text{day}^{-1}$
1	1×10^8	7×10^5
2	2×10^4	0.2
3	3×10^{-2}	3×10^{-8}

Measured upper limit for the DC in CCDs is:

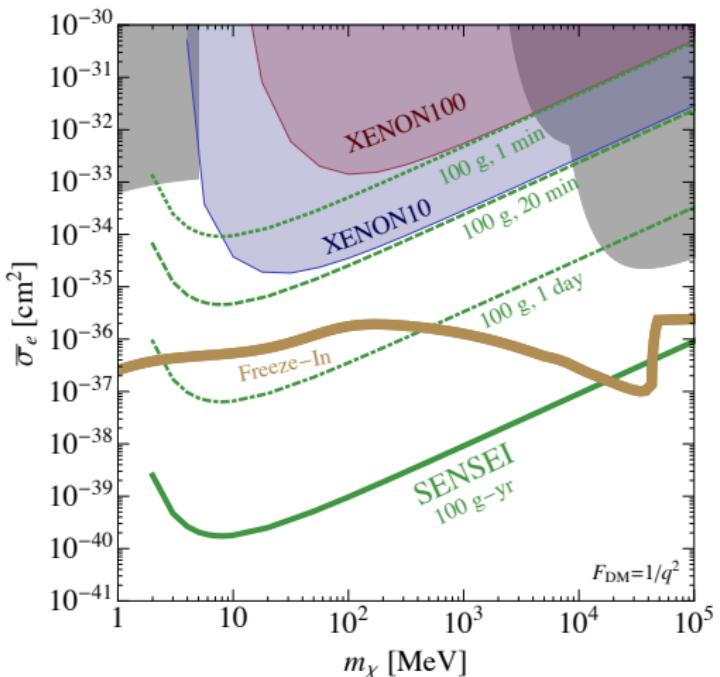
$$1 \times 10^{-3} \text{ e pix}^{-1}\text{day}^{-1} \quad \text{arXiv:1611.03066}$$

Could be orders of magnitude lower. **Theoretical prediction is $O(10^{-7})$**



SENSEI: reach of a 100g, zeroish-background experiment

Light Dark Photon



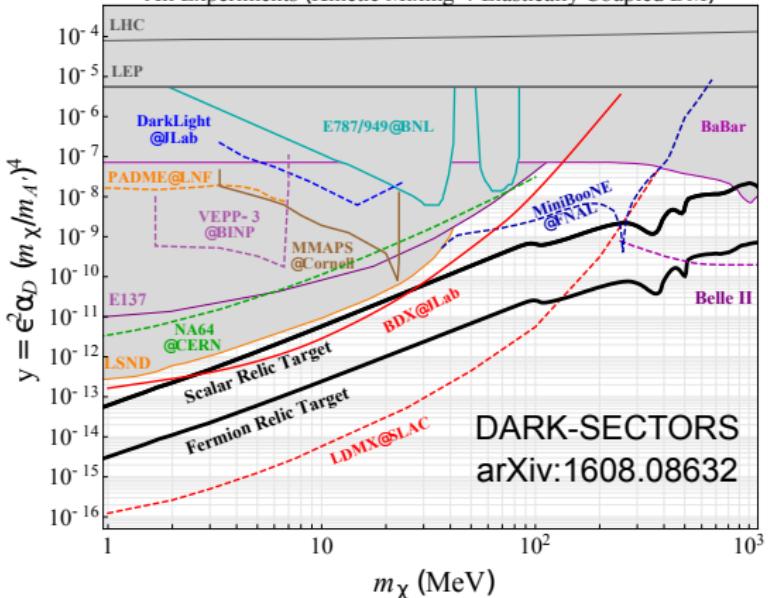
Rouven Essig, Tomer Volansky & Tien-Tien Yu.



SENSEI: reach of a 100g, zeroish-background experiment

Heavy Dark Photon

All Experiments (Kinetic Mixing + Elastically Coupled DM)

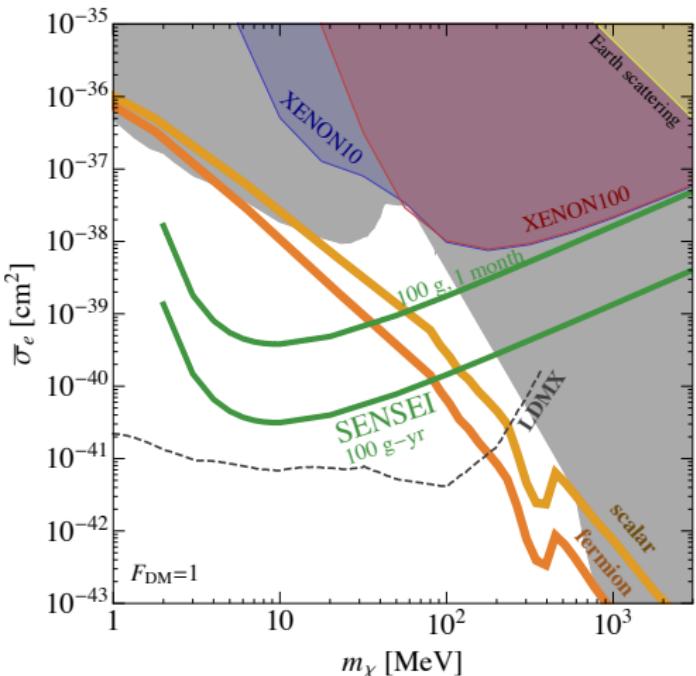


$$\bar{\sigma}_e \simeq \begin{cases} \frac{16\pi\mu_e^2 \alpha \alpha_D \epsilon^2}{m_{A'}^4}, & m_{A'} \gg \alpha m_e \\ \frac{16\pi\mu_e^2 \alpha \alpha_D \epsilon^2}{(\alpha m_e)^4}, & m_{A'} \ll \alpha m_e \end{cases}, \text{ and } F_{DM}(q) \simeq \begin{cases} 1, & m_{A'} \gg \alpha m_e \\ \frac{\alpha^2 m_e^2}{q^2}, & m_{A'} \ll \alpha m_e \end{cases}$$



SENSEI: reach of a 100g, zeroish-background experiment

Heavy Dark Photon: complementary to LDMX

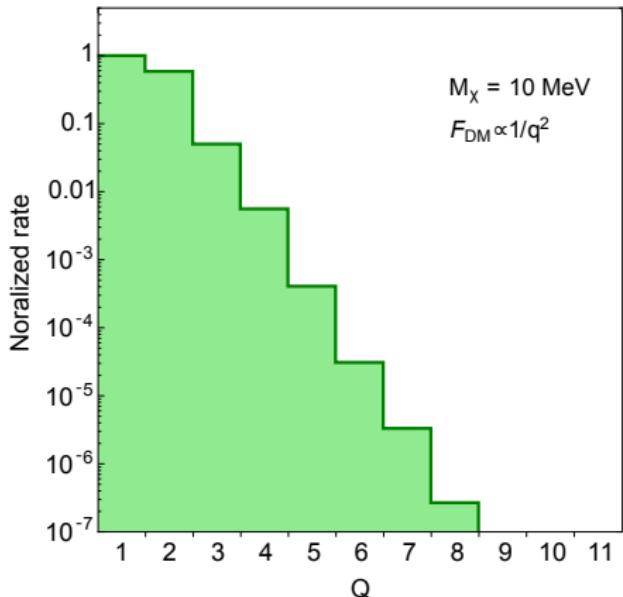
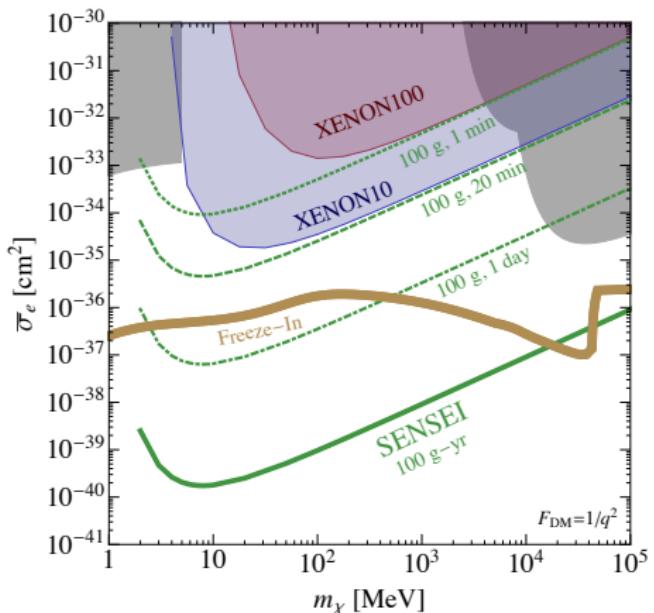


Rouven Essig, Tomer Volansky & Tien-Tien Yu.



SENSEI: electron recoil background requirements

The sensitivity is dominated by the lowest energy/charge bin



Rouven Essig, Tomer Volansky & Tien-Tien Yu.

SENSEI: electron recoil background requirements

Back of the envelope calculation

A 100g detector that takes data for one year → **Expo = 36.5kg · day**

Assuming same background as in DAMIC:

- **5 DRU** (events·kg⁻¹·day⁻¹·keV⁻¹) in the 0-1keV range
→ $N_{\text{bkg}} = 36.5 \text{ kg} \cdot \text{day} \times 5 \text{ DRU} = 182.5 \text{ events}$
- Dominated by external gammas → flat Compton spectrum

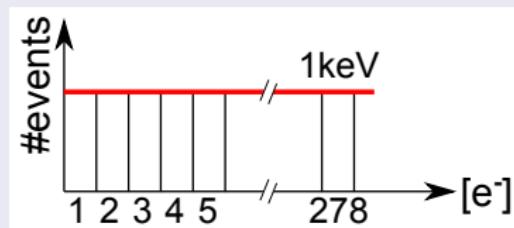
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182.5 events over the 278 charge bins in the 0-1keV range

Expect 0.65 bkd events in the lowest (2 e⁻) charge-bin

Summary

- Demonstrated technology: working detector
- Demonstrated bkg: no R&D needed.
 - ▶ this level already reached by running experiments
- Minimal R&D required for the packaging of the sensors.
- 100 g construction could start on FY18.
 - ▶ 1.2 M\$ in 2 yrs (scaled from DAMIC experience)
- Complementary to LDMX and DAMIC-1K
- Small scale demonstration at the MINOS. Results by the end of 2017.
- MINOS site is good up to a 10g experiment. SURF/Snolab for 100g.

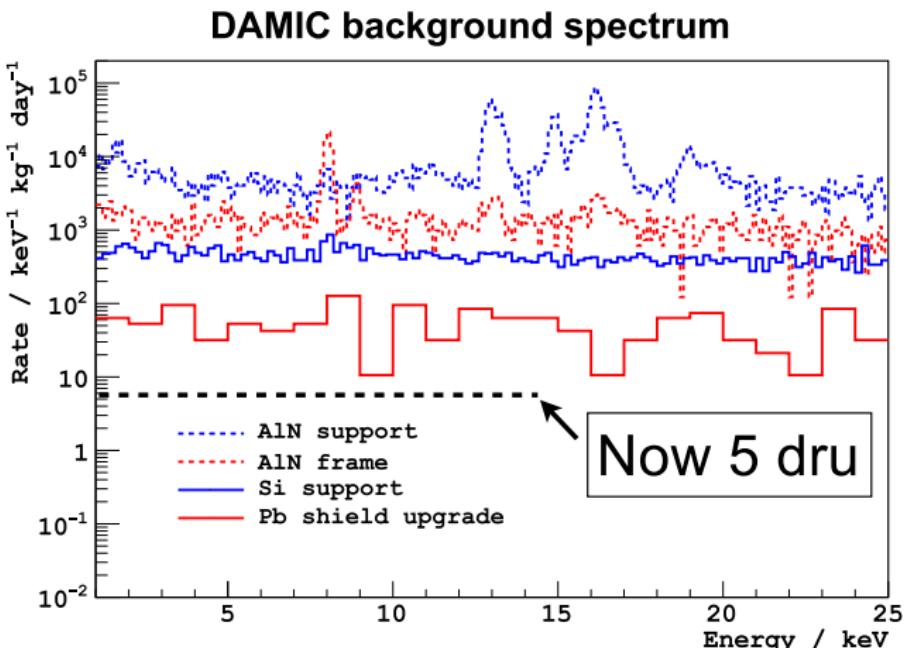
BACK UP SLIDES

SENSEI budget draft

	M&S	Effort	Total
1. Sensors & package	350 k\$	100 k\$	450 k\$
2. Readout electronics	200 k\$	0 k\$	200 k\$
3. Vessel & support systems	115 k\$	100 k\$	215 k\$
4. Installation	0 k\$	50 k\$	50 k\$
5. Contingency	150 k\$	50 k\$	200 k\$
Total	815 k\$	300 k\$	1.15 M\$



DAMIC background



SuperCDMS SNOLAB projected background

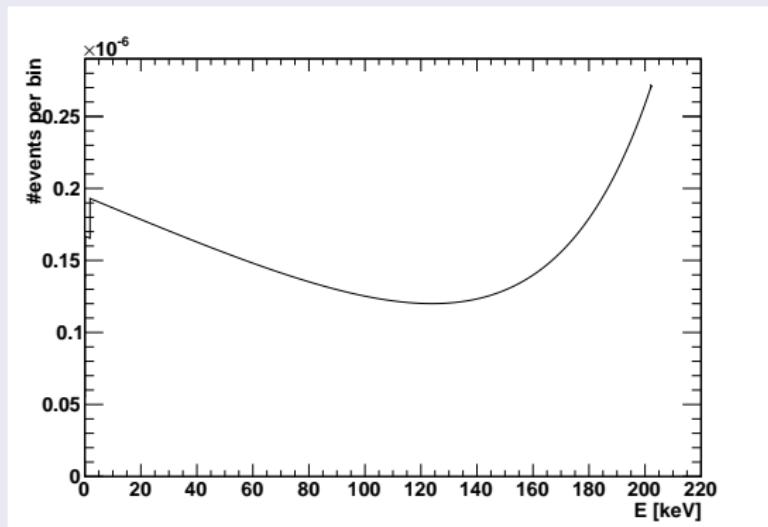
"Singles" Background Rates (counts/kg/keV/year)	Electron Recoil				Nuclear Recoil ($\times 10^{-6}$)	
	Ge HV	Si HV	Ge iZIP	Si iZIP	Ge iZIP	Si iZIP
Coherent Neutrinos					2300.	1600.
Detector-Bulk Contamination	21.	290.	8.5	260.		
Material Activation	1.0	2.5	1.9	15.		
Non-Line-of-Sight Surfaces	0.00	0.03	0.01	0.07	-	
Bulk Material Contamination	5.4	14.	12.	88.	440.	660.
Cavern Environment	-	-	-	-	510.	530.
Cosmogenic Neutrons					73.	77.
Total	27.	300.	22.	370.	3300.	2900.

From arXiv:1610.00006

Skipper CCD - electron recoil background requirements

A more detailed analysis: Klein-Nishina + binding energy correction

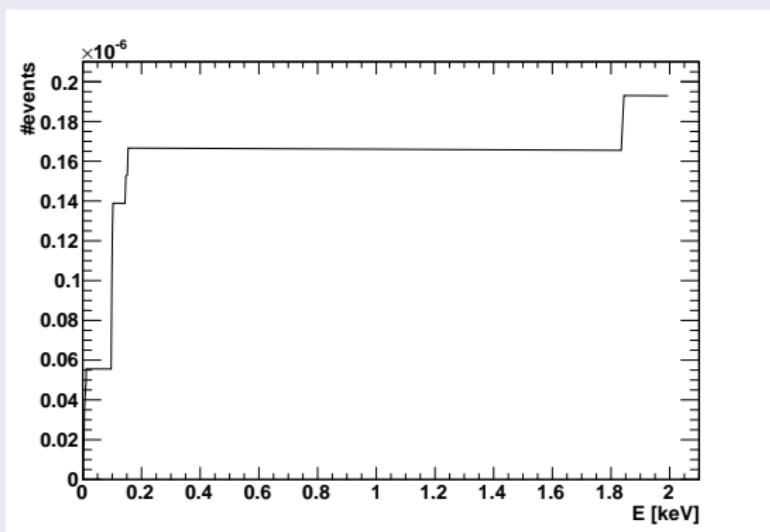
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- partial energy depositions populate low E region (thin det)



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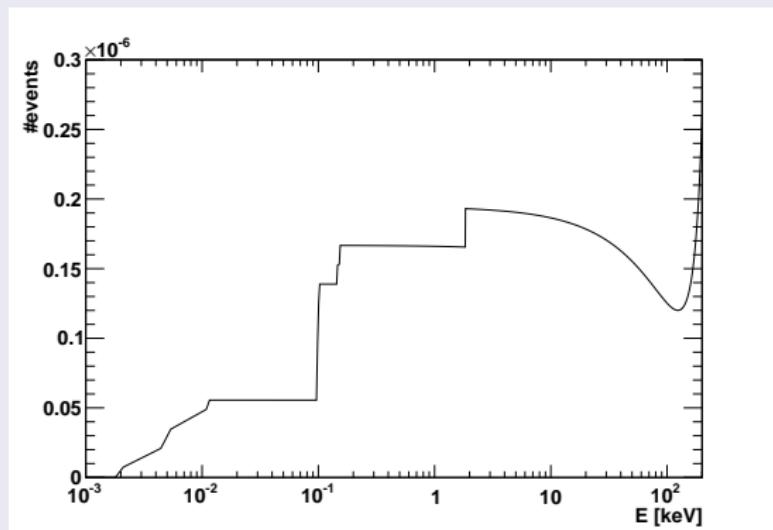
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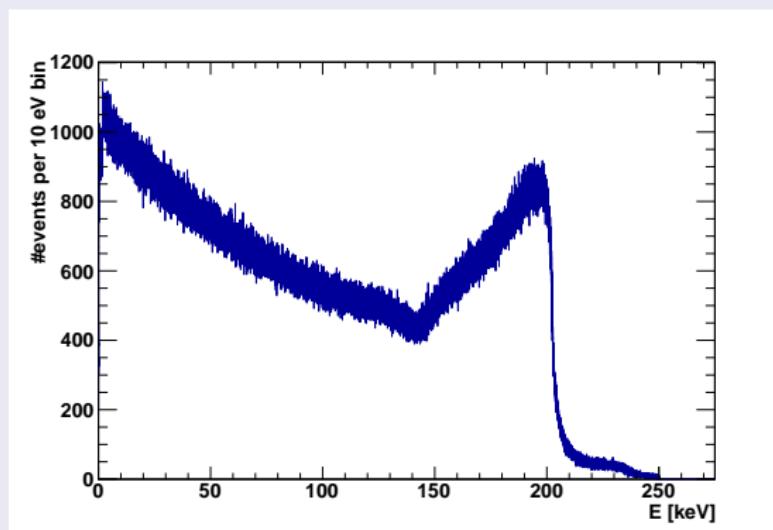
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A more detailed analysis: MC simulation, G4 3D Monash model

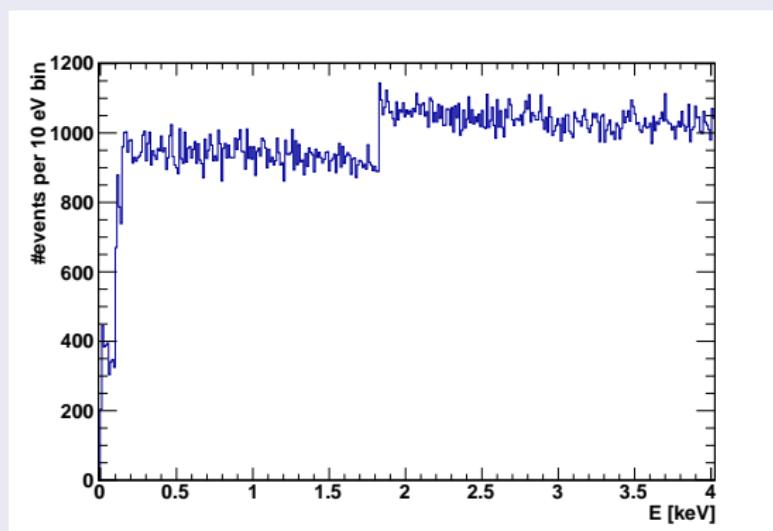
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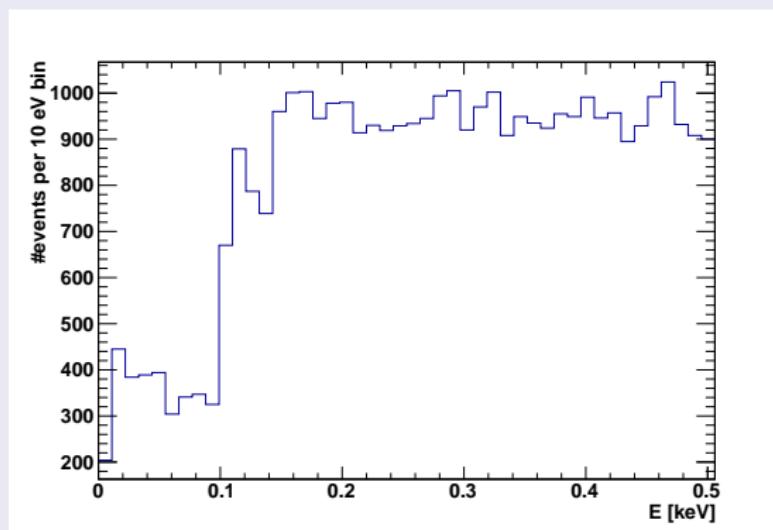
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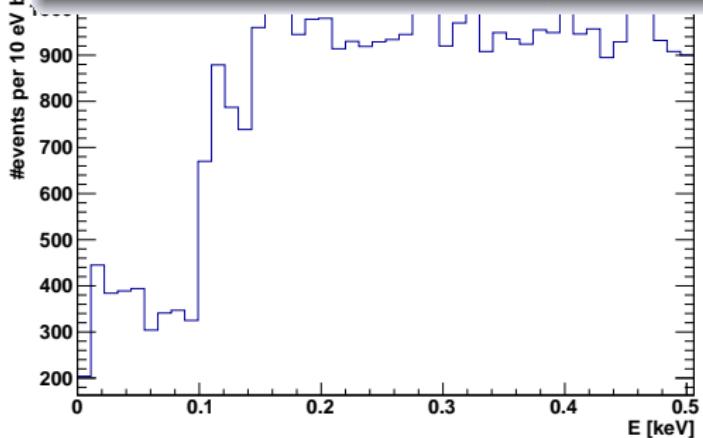


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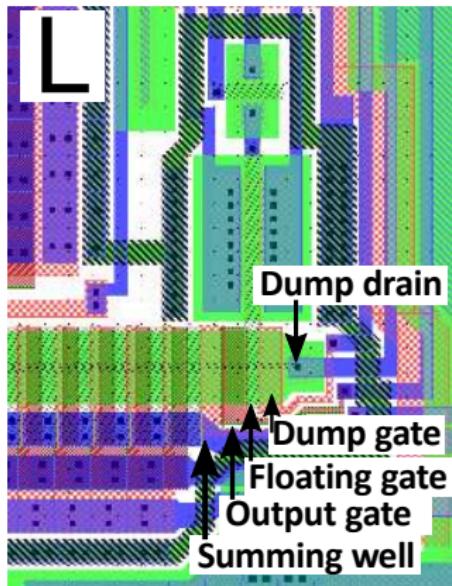
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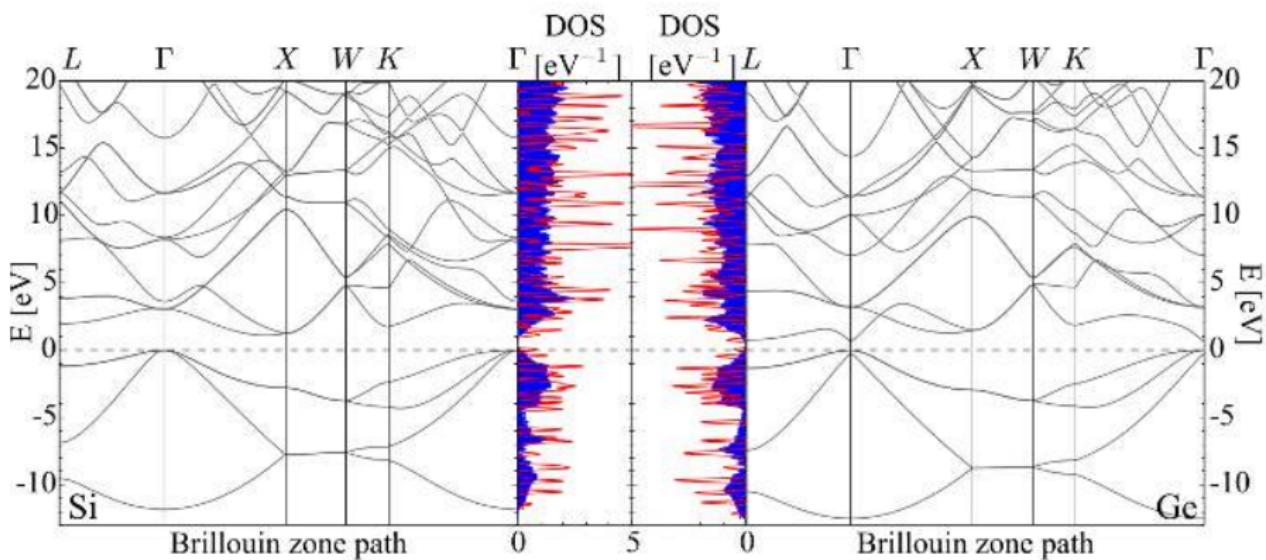
Back of the envelope
estimation is conservative



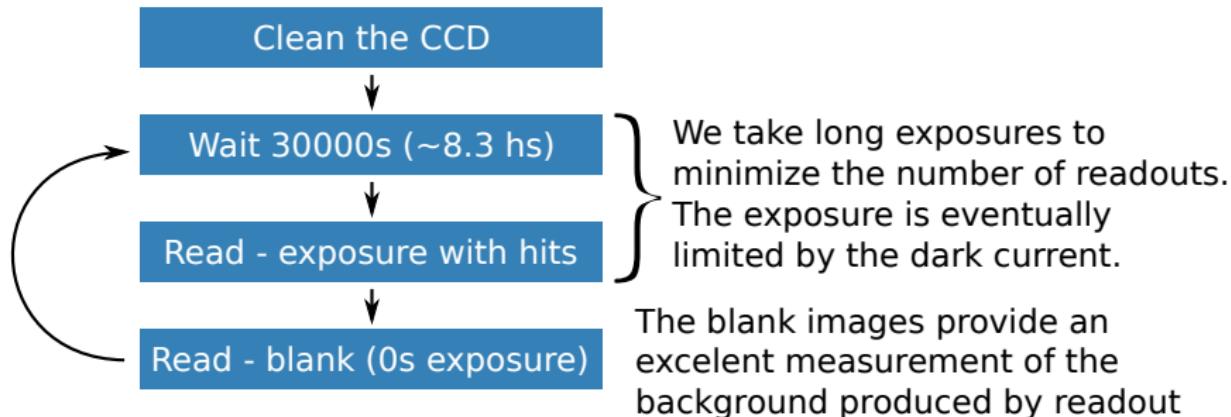
Readout stage design



Electron density-of-states (1509.1598)



CCD: readout - typical operation for rare events searches

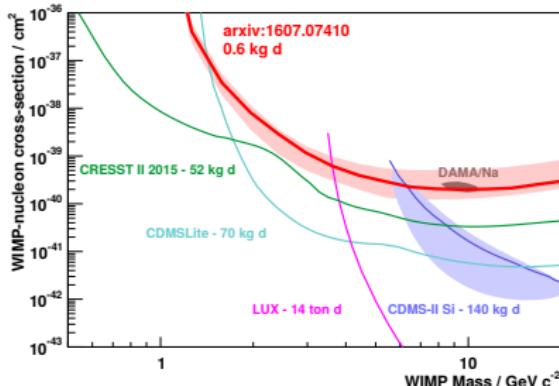


- The number of **real** events (produced by particles) scales with the total exposure time.
- The number of **fake** events (product of readout noise) scale with the number of readings (images taken).

It is better to read as few times as possible.

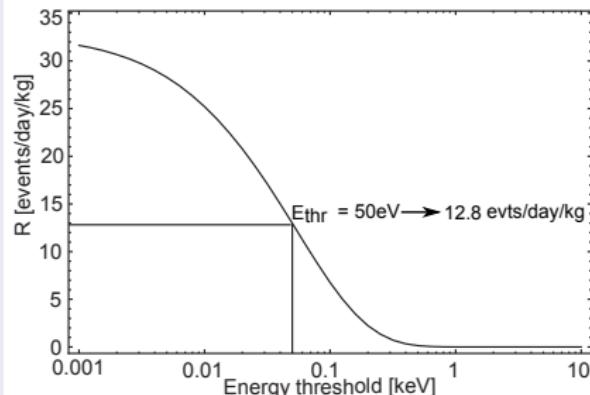
Status of the experiments

DAMIC



- Eng WIMP search: 1607.07410
- Fully commissioned Jan-17

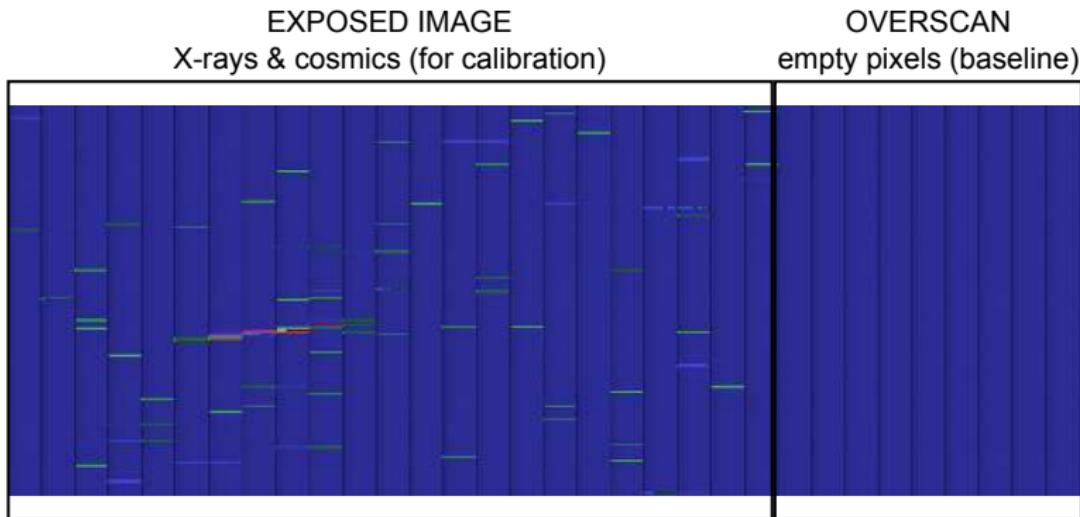
CONNIE



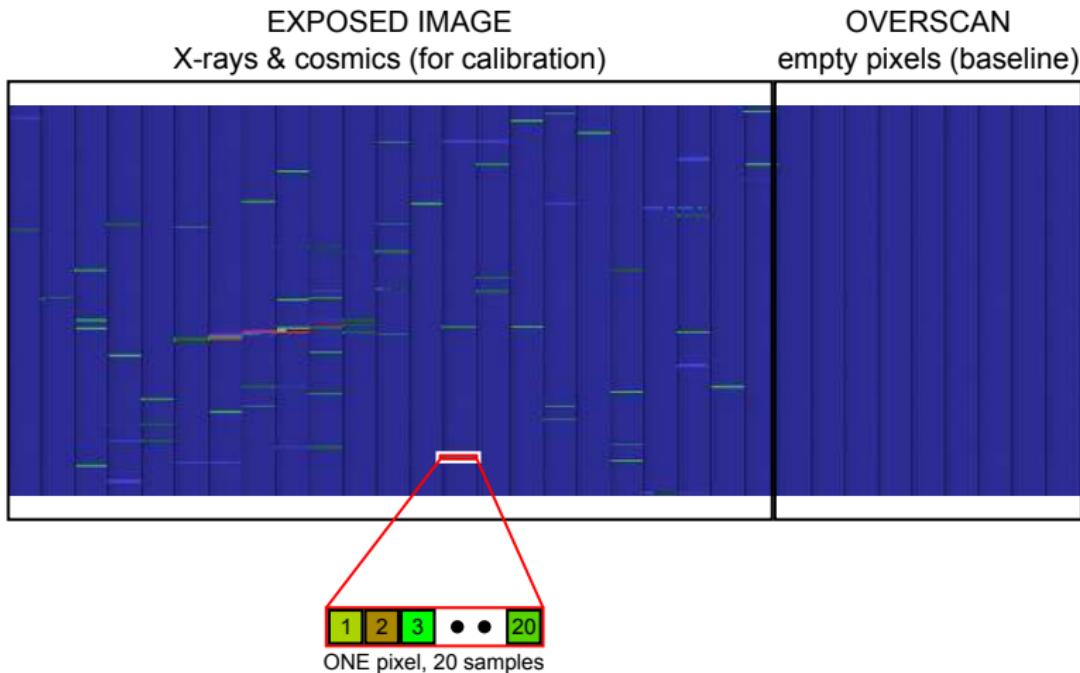
- Eng run: 1604.01343
- Fully commissioned Aug-16

**Both searches are limited by the readout noise of the sensors
Very limited electron-recoil sensitivity: threshold $\sim 10\text{e}^-$**

Raw image taken with SENSEI: 20 samples per pixel



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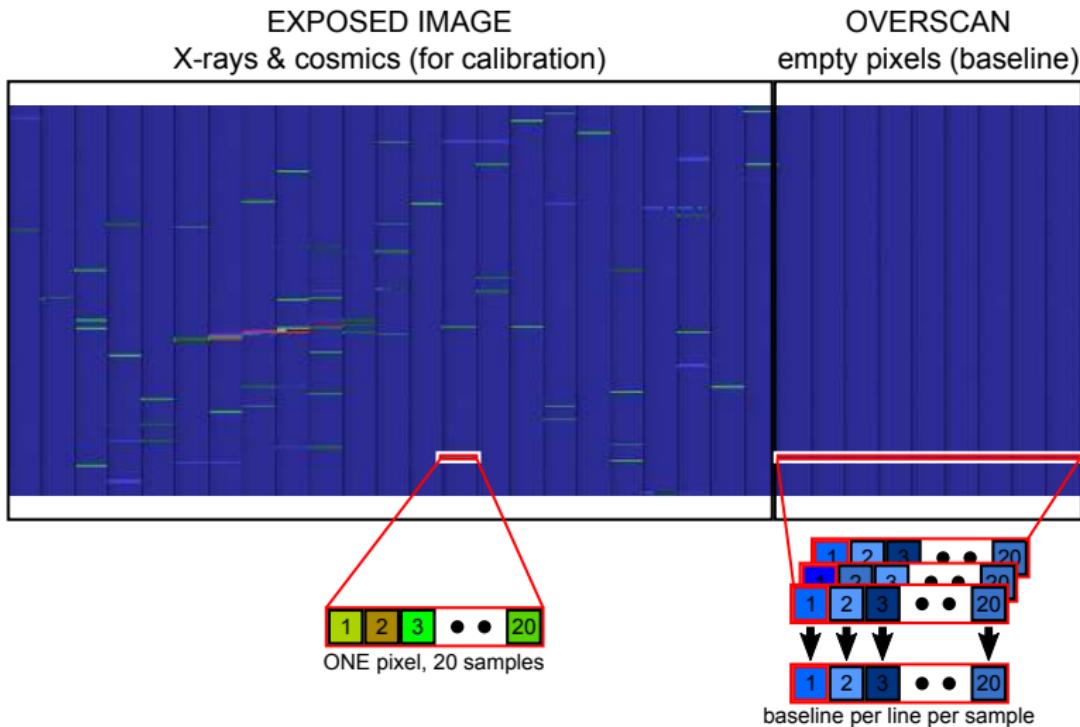
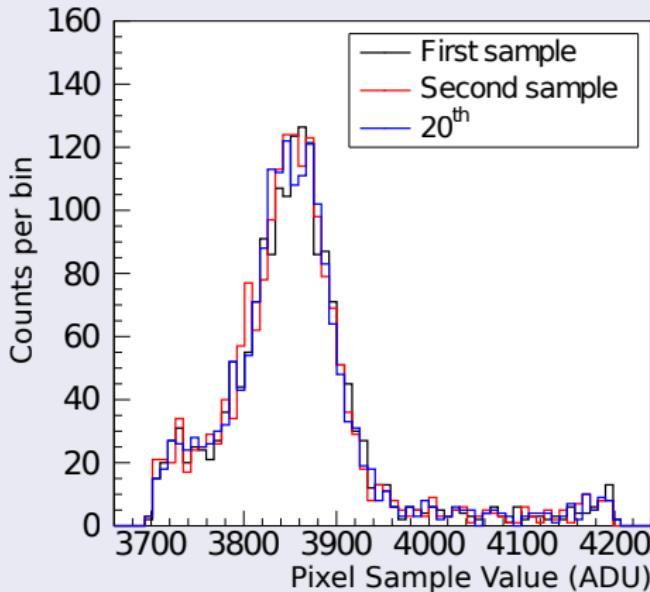


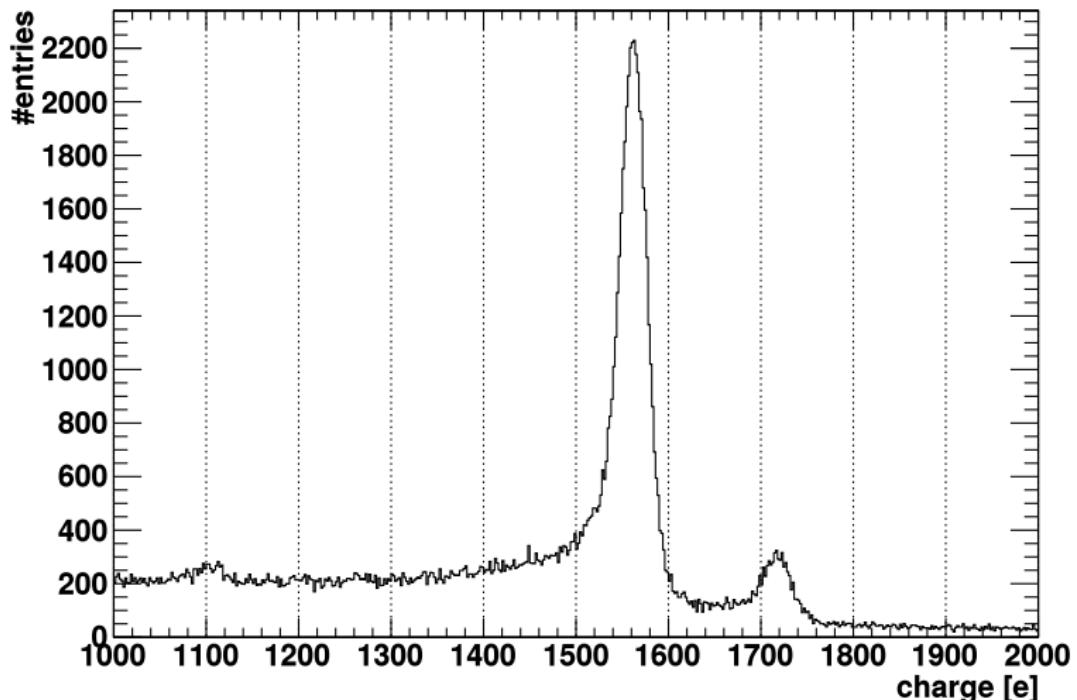
Image taken with SENSEI: 20 samples per pixel

Single pixel distribution: X-rays from ^{55}Fe

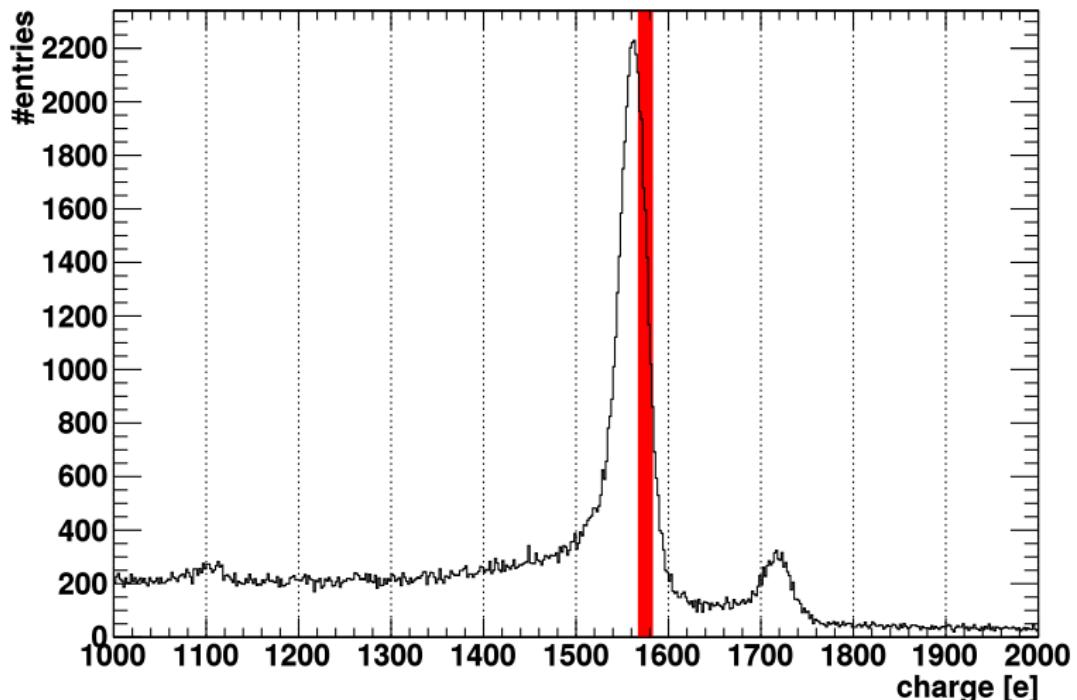


The gain is the same for all the samples

500 samples



500 samples



keep counting: ..1575, 1576, 1577..

